

<b>Notice of References Cited</b>	Application/Control No. 10/535,306	Applicant(s)/Patent Under Reexamination BEGUINOT ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2001-181781	07-2001	Japan	Adachi, Kouji et al.	-----
	O	2001-220648	08-2001	Japan	Furukimi et al.	-----
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**NON-PATENT DOCUMENTS**

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